

Search Notes

Application/Control No.

10/611,501

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

STERRETT ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	777 & 686	3/28/2005	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; EPO; JPO; DERWENT; and IBM_TDB;	3/28/2005	C.C.